



TEST REPORT

Reference No...... : WTN24N01011911R1E
Applicant : Ningbo Ehome electronic Co.,Ltd
Address : Yonghe Road, Qiaotouhu Industrial Zone,Ninghai,Ningbo,China
Manufacturer : Same as applicant
Address : Same as applicant
Product Name : Microwave Sensor
Model No...... : ST701H, ST760, ST701E, ST701F, ST701K, ST701D,
ST701MA, ST701MB
Test specification : EN IEC 55015:2019+A11:2020
EN IEC 61547:2023
EN IEC 61000-3-2:2019+A1:2021+A2:2024
EN 61000-3-3:2013+A1:2019+A2:2021
Date of Receipt sample : 2025-02-11
Date of Test : 2025-02-11
Date of Issue : 2025-02-21
Test Report Form No...... : WEL-55015A-17B
Test Result : **Pass**

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

Prepared By:

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**1 Test Summary**

EMISSION			
Test Item	Test Standard	Class / Severity	Result
Conducted Disturbance, 9 kHz to 30 MHz	EN IEC 55015:2019+A11:2020	Clause 4.3	Pass
Radiated Disturbance, 9 kHz to 30 MHz	EN IEC 55015:2019+A11:2020	Clause 4.5.2	Pass
Radiated Disturbance, 30 MHz to 1 GHz	EN IEC 55015:2019+A11:2020	Clause 4.5.3	Pass
Harmonic Current Emissions	EN IEC 61000-3-2:2019+A1:2021+A2:2024	Clause 7	Pass
Voltage Changes, Voltage Fluctuations and Flicker	EN 61000-3-3:2013+A1:2019+A2:2021	Clause 5	Pass
IMMUNITY (EN IEC 61547:2023)			
Test Item	Test Method	Performance Criteria	Result
Electrostatic Discharge (ESD)	IEC 61000-4-2:2008	B	Pass
Radio-frequency Electromagnetic Fields (80 MHz to 1 GHz)	IEC 61000-4-3:2006+A1:2007+A2:2010	A	Pass
Fast Transients (EFT)	IEC 61000-4-4:2012	B	Pass
Surges	IEC 61000-4-5:2014	C	Pass
Injected Currents, 0.15 MHz to 80 MHz	IEC 61000-4-6:2013	A	Pass
Power-frequency Magnetic Fields	IEC 61000-4-8:2009	A	N/A
Voltage Dips	IEC 61000-4-11:2004+A1:2017	B	Pass
Voltage Short Interruptions		B	Pass

Remark:

Pass

EUTs meet the requirement

Fail

EUTs do not meet the requirement

N/A

EUTs do not apply to the test object



2 Contents

	Page
COVER PAGE	1
1 TEST SUMMARY	2
2 CONTENTS	3
3 REVISION HISTORY	5
4 GENERAL INFORMATION	6
4.1 GENERAL DESCRIPTION OF E.U.T.	6
4.2 DETAILS OF E.U.T.	6
4.3 DESCRIPTION OF SUPPORT UNITS	7
4.4 STANDARDS APPLICABLE FOR TESTING	7
4.5 SUBCONTRACTED.....	7
4.6 ABNORMALITIES FROM STANDARD CONDITIONS.....	7
5 EQUIPMENT USED DURING TEST	8
5.1 MEASUREMENT UNCERTAINTY	9
6 EMISSION TEST RESULTS	10
6.1 CONDUCTED DISTURBANCE, 9 KHZ TO 30 MHZ	10
6.1.1 E.U.T. Operation	10
6.1.2 Block Diagram of Test Setup	10
6.1.3 Measurement Data	10
6.1.4 Electric Power Supply Interface Disturbance Voltage Test Data.....	11
6.2 RADIATED DISTURBANCE, 9 KHZ TO 30 MHZ	13
6.2.1 E.U.T. Operation	13
6.2.2 Block Diagram of Test Setup	14
6.2.3 Measurement Data	14
6.2.4 Radiated Disturbance Test Data, 9 kHz to 30 MHz.....	15
6.3 RADIATED DISTURBANCE, 30 MHZ TO 1 GHZ	18
6.3.1 E.U.T. Operation	18
6.3.2 Block Diagram of Setup	18
6.3.3 Measurement Data	18
6.3.4 Radiated Disturbance Test Data, 30 MHz to 1 GHz.....	19
6.4 HARMONIC CURRENT EMISSIONS.....	21
6.4.1 E.U.T. Operation	21
6.4.2 Block Diagram of Setup	21
6.4.3 Harmonic Current Emissions Test Data	22
6.5 VOLTAGE CHANGES, VOLTAGE FLUCTUATIONS AND FLICKER	23
6.5.1 E.U.T. Operation	23
6.5.2 Block Diagram of Setup	23
6.5.3 Voltage Changes, Voltage Fluctuations and Flicker Test Data.....	23
7 IMMUNITY TEST RESULTS	24
7.1 PERFORMANCE CRITERIA	24
7.2 ELECTROSTATIC DISCHARGE (ESD).....	24
7.2.1 E.U.T. Operation	24
7.2.2 Block Diagram of Setup	25
7.2.3 Direct Discharge Test Results	25
7.2.4 Indirect Discharge Test Results.....	26
7.3 RADIO-FREQUENCY ELECTROMAGNETIC FIELDS, 80 MHZ TO 1 GHZ.....	27
7.3.1 E.U.T. Operation	27
7.3.2 Block Diagram of Setup	28
7.3.3 Test Results.....	28



7.4	FAST TRANSIENTS (EFT).....	29
7.4.1	E.U.T. Operation	29
7.4.2	Block Diagram of Setup	30
7.4.3	Test Results	30
7.5	SURGES.....	31
7.5.1	E.U.T. Operation	31
7.5.2	Block Diagram of Setup	31
7.5.3	Test Results	31
7.6	INJECTED CURRENTS IMMUNITY, 0.15 MHz TO 80 MHz.....	32
7.6.1	E.U.T. Operation	32
7.6.2	Block Diagram of Setup	32
7.6.3	Test Results	32
7.7	VOLTAGE DIPS AND SHORT INTERRUPTIONS	33
7.7.1	E.U.T. Operation	33
7.7.2	Block Diagram of Setup	33
7.7.3	Test Results	33
8	PHOTOGRAPHS - TEST SETUP	34
8.1	PHOTOGRAPH - ELECTRIC POWER SUPPLY INTERFACE DISTURBANCE VOLTAGE TEST SETUP	34
8.2	PHOTOGRAPH - RADIATED DISTURBANCE TEST SETUP, 9 kHz TO 30 MHz.....	34
8.3	PHOTOGRAPH - RADIATED DISTURBANCE TEST SETUP, 30 MHz TO 1 GHz.....	35
8.4	PHOTOGRAPH - HARMONIC CURRENT AND VOLTAGE CHANGES, VOLTAGE FLUCTUATION AND FLICKER TEST SETUP	35
8.5	PHOTOGRAPH - ESD IMMUNITY TEST SETUP	36
8.6	PHOTOGRAPH - RADIO-FREQUENCY ELECTROMAGNETIC FIELDS IMMUNITY TEST SETUP	36
8.7	PHOTOGRAPH - EFT & VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST SETUP	37
8.8	PHOTOGRAPH - SURGES IMMUNITY TEST SETUP.....	37
8.9	PHOTOGRAPH - INJECTED CURRENTS IMMUNITY TEST SETUP.....	38
9	PHOTOGRAPHS - CONSTRUCTIONAL DETAILS.....	39
9.1	PHOTO - APPEARANCE VIEW	39



3 Revision History

Test report No.	Date of receipt	Date of test	Date of issue	Purpose	Comment	Approved
WTN24N01011911E	2024-01-16	2024-01-18 to 2024-01-22	2024-01-23	Original	-	Valid
WTN24N01011911R1E	2025-02-11	2025-02-11	2025-02-21	Supplement (1)	Updated standard and added models	Valid

Remark:

(1) This report No. WTN24N01011911R1E is based on the original report No. WTN24N01011911E, updated standard and added models. For details information, refer to the section 4.1.

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4 General Information

4.1 General Description of E.U.T.

- Product Name** : Microwave Sensor
- Model No.** : ST701H, ST760, ST701E, ST701F, ST701K, ST701D, ST701MA, ST701MB
- Protection Class** : Class II
- Remark** :
- The EUT (equipment under test) is Microwave Sensor for lighting and similar use. For the further information, refer to the user's manual.
 - This report has updated the following content based on the original report No. WTN24N01011911E, the update of this content does not involve testing.
 - The standard has been updated, with Standard "EN IEC 61000-3-2:2019+A1:2021" updated to "EN IEC 61000-3-2:2019+A1:2021+A2:2024".
 - Added models. Model No.2 - No.8 have been added this time. These models have a similar circuit principle and PCB layout to the original report's main test model ST701H, except for their appearance. Therefore, the testing of these models can be covered by the original report's main test model ST701H, without the need for testing.
 - In electrical characteristics, all models are similar circuit principle and PCB layout, except for power and appearances. For details information, refer to the section 4.2.
 - For the test results, the EUT had been tested with the rated input range. But only the worst case was shown in test report.

4.2 Details of E.U.T.

No.	Model	Rated Input	Max Power	Note
1.	ST701H	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp
2.	ST760	220 - 240 Vac, 50 / 60 Hz	600 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp
3.	ST701E	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp
4.	ST701F	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp
5.	ST701K	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp



No.	Model	Rated Input	Max Power	Note
6.	ST701D	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp
7.	ST701MA	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp
8.	ST701MB	220 - 240 Vac, 50 / 60 Hz	1200 W	Incandescent Lamp
			300 W	LED Light LED/Energy saving lamp

4.3 Description of Support Units

The EUT has been tested as an independent unit. ST701H is the tested sample. All tests were performed in the condition of 230 Vac, 50 Hz input.

4.4 Standards Applicable for Testing

The tests were performed according to following standards:

EN IEC 55015:2019+A11:2020

Limits and methods of measurement of radio disturbance characteristics of electrical lighting and similar equipment

EN IEC 61547:2023

Equipment for general lighting purposes — EMC immunity requirements

EN IEC 61000-3-2:2019+A1:2021+A2:2024

Electromagnetic compatibility (EMC) Part 3-2: Limits — Limits for harmonic current emissions (equipment input current ≤ 16 A per phase).

EN 61000-3-3:2013+A1:2019+A2:2021

Electromagnetic compatibility (EMC) Part 3-3: Limits — Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection.

4.5 Subcontracted

Whether parts of tests for the product have been subcontracted to other labs:

Yes No

If Yes, list the related test items and lab information:

Test items: ---

Lab information: ---

Address:---

4.6 Abnormalities from Standard Conditions

None.

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**5 Equipment Used during Test**

Conducted Disturbance					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	EMI Test Receiver	R&S	ESCI	101406	Valid
2	TWO-LINE V-NETWORK	R&S	ENV216	101208	Valid
3	EZ-EMC	Farad Technology	RA-03A1-A	/	/
Radiated Disturbance (9 kHz to 30 MHz)					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	EMI Test Receiver	R&S	ESCI	101406	Valid
2	3-dimensional large loop antenna	SCHWARZBECK	HXYZ9170	256	Valid
3	EZ-EMC	Farad Technology	RA-03A1-A	/	/
Radiated Disturbance (30 MHz to 1 GHz)					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	EMI Test Receiver	R&S	ESR7	101777	Valid
2	TRILOG Biconic logarithmic periodic broadband antenna	SCHWARZBECK	VULB9163	01025	Valid
3	coupling-Decoupling Network	SCHWARZBECK	CDNE M3	00081	Valid
4	coupling-Decoupling Network	SCHWARZBECK	CDNE M2	00093	Valid
5	EZ-EMC	Farad Technology	EMEC-03A1	/	/
Harmonic Current and Voltage Changes, Voltage Fluctuations and Flicker Measuring System					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	Harmonics /Flicker Analyzer	KIKUSUI	KHA1000	TL002966	Valid
2	line Power Supply	KIKUSUI	PCR4000LE	TL003094	Valid
3	Line Impedance Network	KIKUSUI	LIN40MA-PCR-LE	TM001297	Valid
4	Harmo Capture	KIKUSUI	Ver.3.9x	/	/
ESD					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	electrostatic discharge generator	TESEQ	NSG437	699	Valid
Radio-frequency Electromagnetic Fields					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	Power Amplifier	SKET	HAP_80M01G-250W	-	Valid
2	Power Amplifier	SKET	HAP_01G06G-75W	-	Valid
3	Stacked log periodic antenna	SKET	STLP 9129 Plus	-	Valid



4	Analog Signal Generator	Agilent	N5181A	MY48180307	Valid
5	Power meter	R&S	NRP-Z11	106957	Valid
6	Power meter	R&S	NRP-Z11	118349	Valid
7	Field strength probe	FRANKONIA	EFS-10	811ZX10321	Valid
8	EMC-S	SKET	V2.1.1.26	/	/

EFT & Voltage Dips and Short Interruptions

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	Multifunction Generator Systems	TESEQ	NSG3040	2094	Valid
2	Single way manual Step regulator	TESEQ	INA 6501	243	Valid

Surges

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	Multifunction Generator Systems	TESEQ	NSG3060	1654	Valid
2	coupling-Decoupling Network	TESEQ	CDN3061	1485	Valid

Injected Currents

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1	Test System for Conducted and Radiated Immunity	TESEQ	NSG4070	37519	Valid
2	Coupling and Decoupling Network	TESEQ	CDN M016	37358	Valid
3	Attenuator	TESEQ	ATN6075	36917	Valid

5.1 Measurement Uncertainty

Test Item	Frequency Range	Uncertainty	Note
Conducted Disturbance	9 kHz - 150 kHz	± 3.32 dB	(1)
Conducted Disturbance	150 kHz - 30 MHz	± 3.11 dB	(1)
Radiated Disturbance	9 kHz - 30 MHz	± 3.06 dB	(1)
Radiated Disturbance	30 MHz - 1 GHz	± 5.26 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



6 Emission Test Results

6.1 Conducted Disturbance, 9 kHz to 30 MHz

Test Requirement..... : EN IEC 55015

Test Method..... : CISPR 16-2-1 and Clause 8.3 of EN IEC 55015

Test Result..... : Pass

Frequency Range..... : 9 kHz to 30 MHz

Class/Severity : Table 1 of EN IEC 55015

6.1.1 E.U.T. Operation

Operating Environment:

Temperature : 23.8 °C

Humidity..... : 52%RH

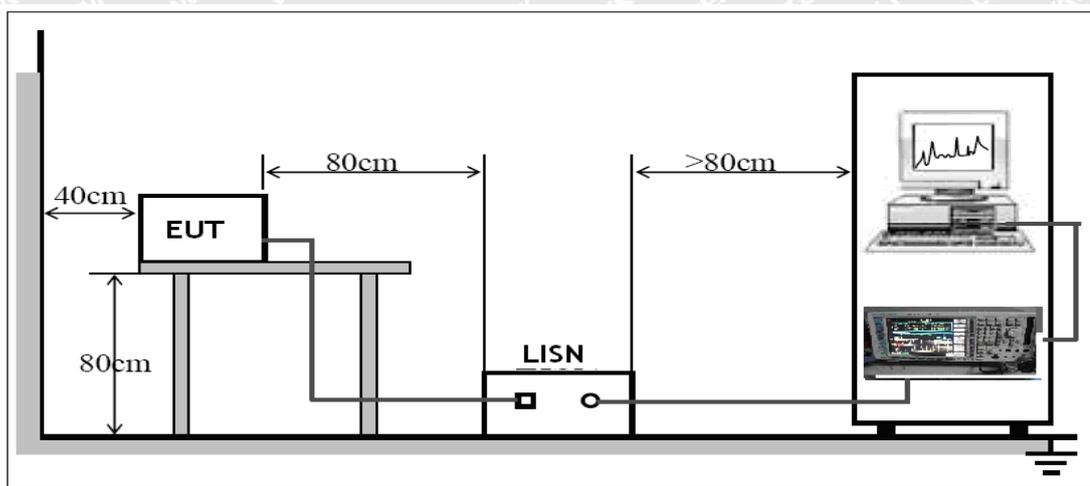
EUT Operation:

Input Voltage : 230 Vac, 50 Hz

Operating Mode..... : Max time + Max lux + Max sens mode

6.1.2 Block Diagram of Test Setup

The Conducted Disturbance tests were performed in accordance with the EN IEC 55015.



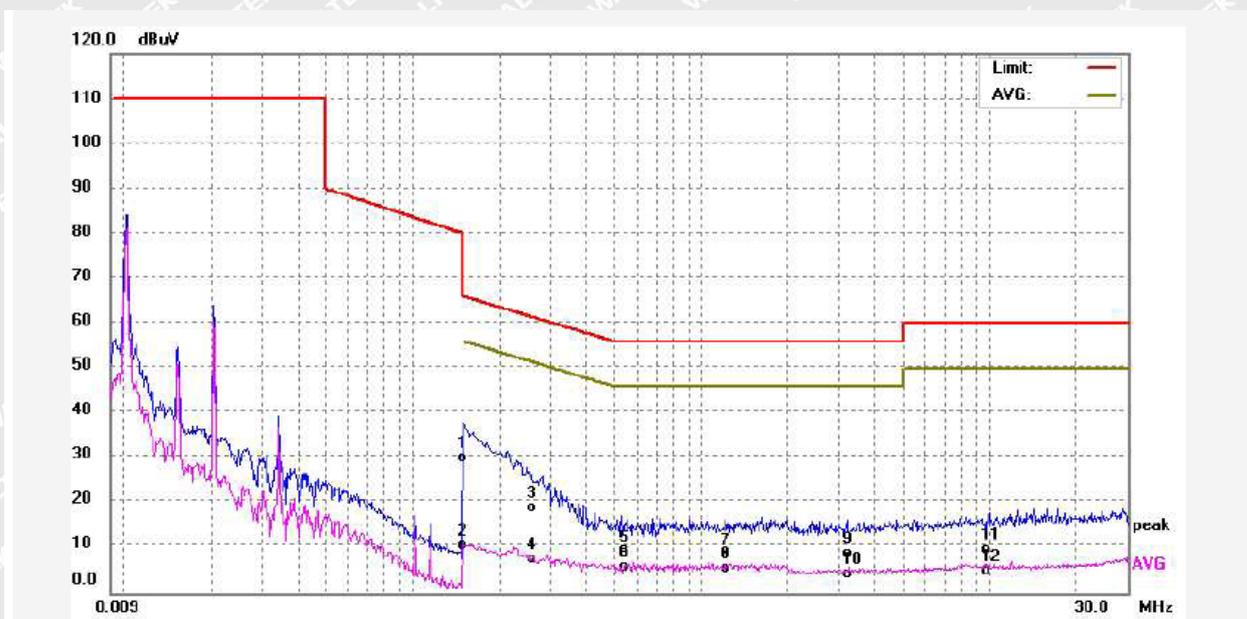
6.1.3 Measurement Data

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6 dB of the average limit line.



6.1.4 Electric Power Supply Interface Disturbance Voltage Test Data

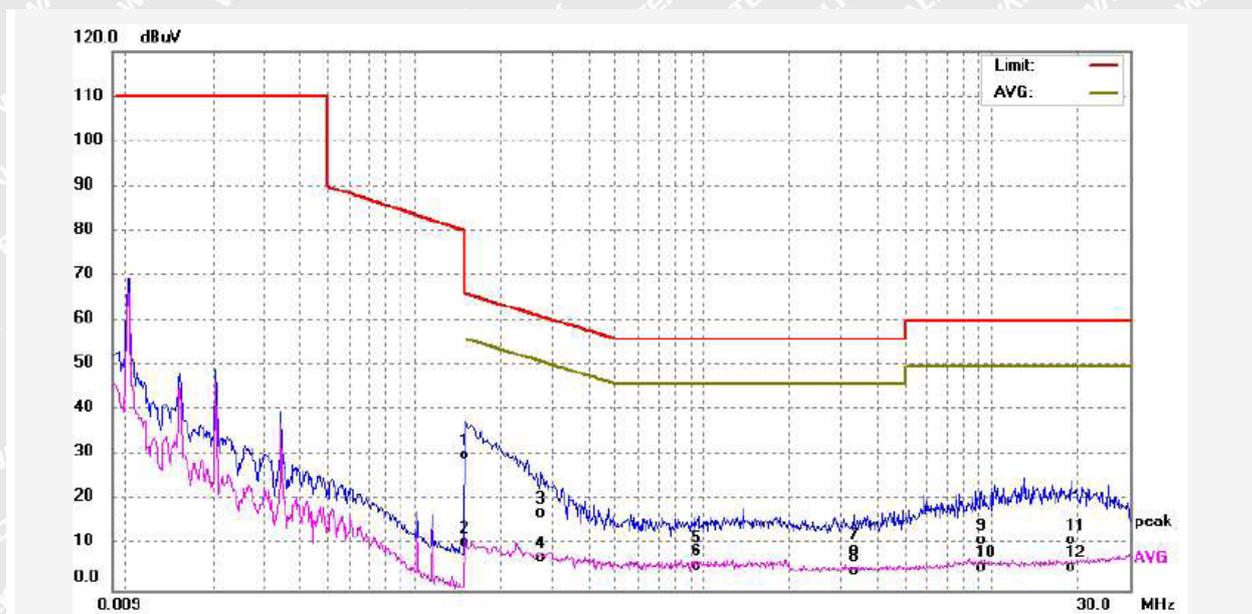
Live Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit dBuV	Margin (dB)	Detector	Remark
1	0.1501	20.35	9.67	30.02	65.99	-35.97	QP	
2	0.1501	0.94	9.67	10.61	55.99	-45.38	AVG	
3	0.2587	9.49	9.68	19.17	61.47	-42.30	QP	
4	0.2587	-2.04	9.68	7.64	51.47	-43.83	AVG	
5	0.5301	-0.66	9.69	9.03	56.00	-46.97	QP	
6	0.5301	-3.86	9.69	5.83	46.00	-40.17	AVG	
7	1.2181	-1.29	9.85	8.56	56.00	-47.44	QP	
8	1.2181	-4.25	9.85	5.60	46.00	-40.40	AVG	
9	3.2141	-0.93	9.86	8.93	56.00	-47.07	QP	
10	3.2141	-5.53	9.86	4.33	46.00	-41.67	AVG	
11	10.0021	-0.47	10.16	9.69	60.00	-50.31	QP	
12	10.0021	-5.22	10.16	4.94	50.00	-45.06	AVG	



Neutral Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit dBuV	Margin (dB)	Detector	Remark
1	0.1501	20.61	9.67	30.28	65.99	-35.71	QP	
2	0.1501	0.88	9.67	10.55	55.99	-45.44	AVG	
3	0.2781	7.71	9.68	17.39	60.87	-43.48	QP	
4	0.2781	-2.38	9.68	7.30	50.87	-43.57	AVG	
5	0.9661	-1.16	9.82	8.66	56.00	-47.34	QP	
6	0.9661	-4.27	9.82	5.55	46.00	-40.45	AVG	
7	3.3101	-0.73	9.87	9.14	56.00	-46.86	QP	
8	3.3101	-5.47	9.87	4.40	46.00	-41.60	AVG	
9	9.2301	1.09	10.16	11.25	60.00	-48.75	QP	
10	9.2301	-4.91	10.16	5.25	50.00	-44.75	AVG	
11	18.8541	0.90	10.48	11.38	60.00	-48.62	QP	
12	18.8541	-5.17	10.48	5.31	50.00	-44.69	AVG	



6.2 Radiated Disturbance, 9 kHz to 30 MHz

Test Requirement..... : EN IEC 55015

Test Method..... : CISPR 16-2-3 and Clause 9.3.2 of EN IEC 55015

Test Result..... : Pass

Frequency Range..... : 9 kHz to 30 MHz

Class/Severity : Table 7 and Table 8 of EN IEC 55015

6.2.1 E.U.T. Operation

Operating Environment:

Temperature : 23.8 °C

Humidity..... : 52%RH

EUT Operation:

Input Voltage : 230 Vac, 50 Hz

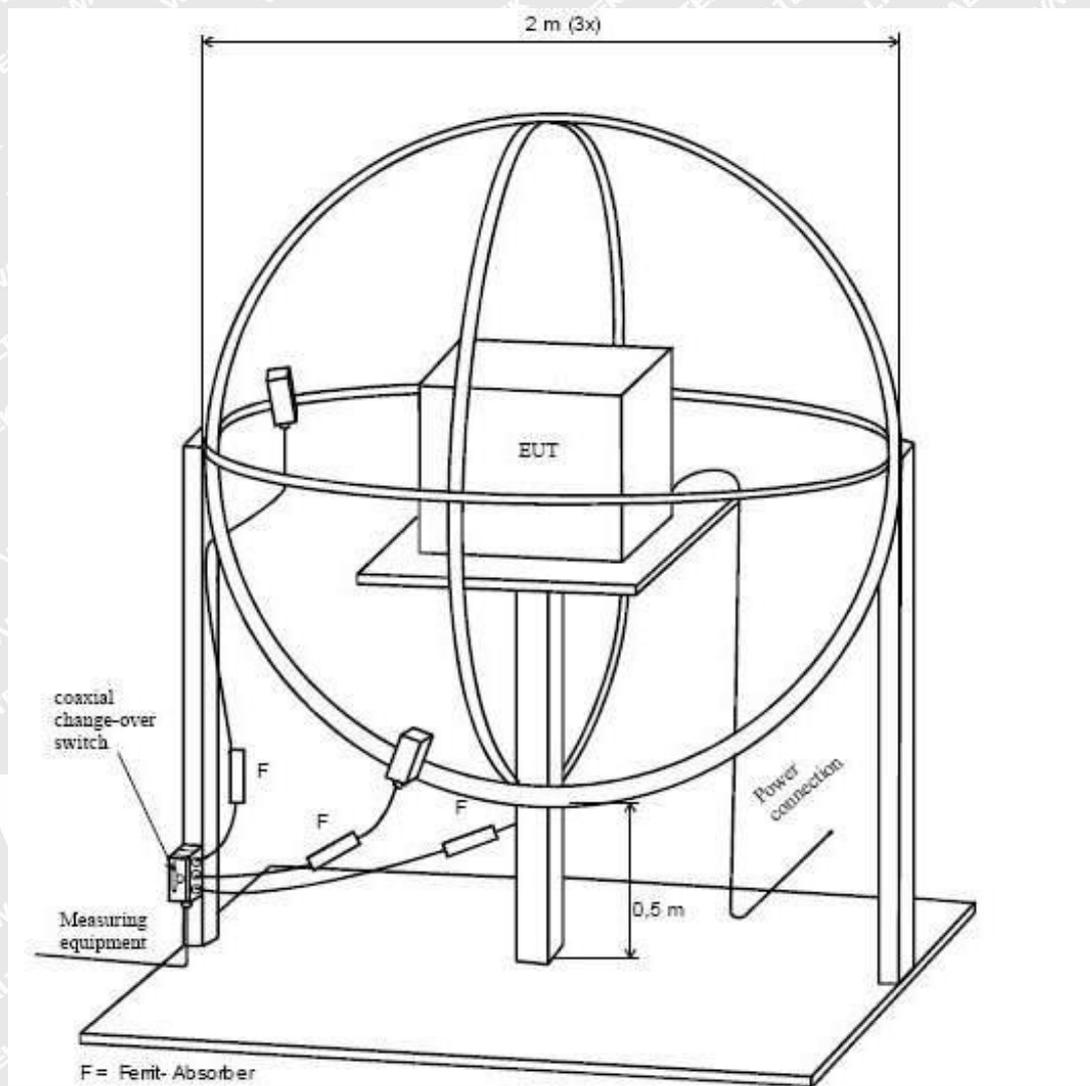
Operating Mode..... : Max time + Max lux + Max sens mode

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6.2.2 Block Diagram of Test Setup

The Radiated Disturbance (9 kHz to 30 MHz) test was performed in accordance with the EN IEC 55015.

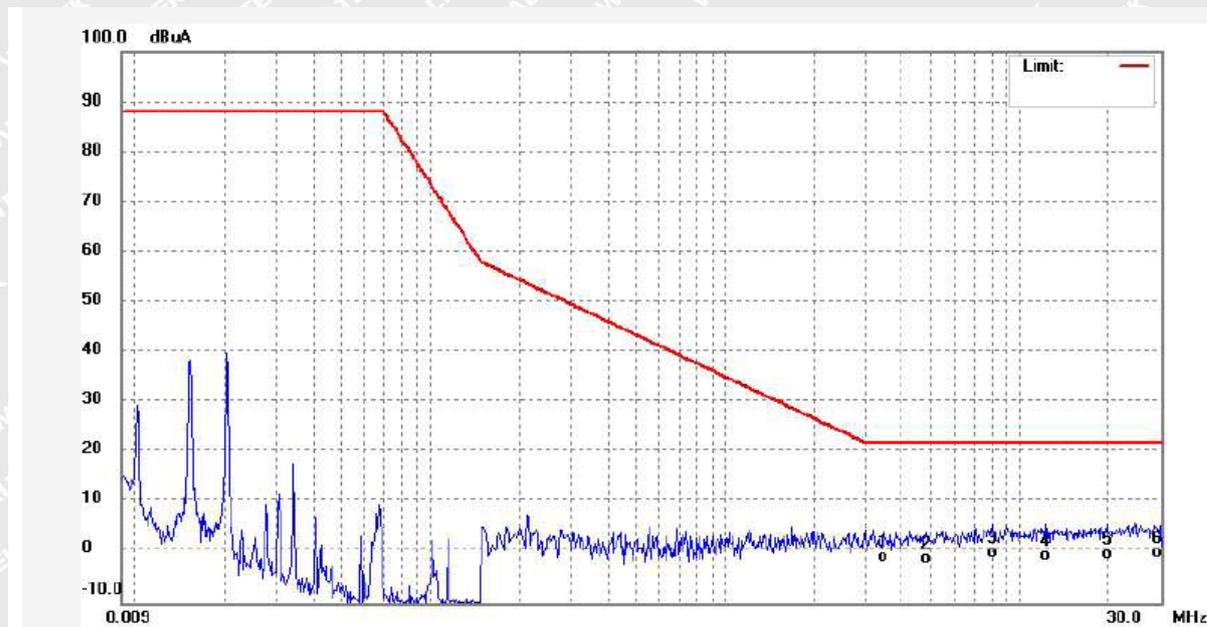


6.2.3 Measurement Data

According to the data in section 6.2.4, the EUT complied with the EN IEC 55015 standards.

**6.2.4 Radiated Disturbance Test Data, 9 kHz to 30 MHz**

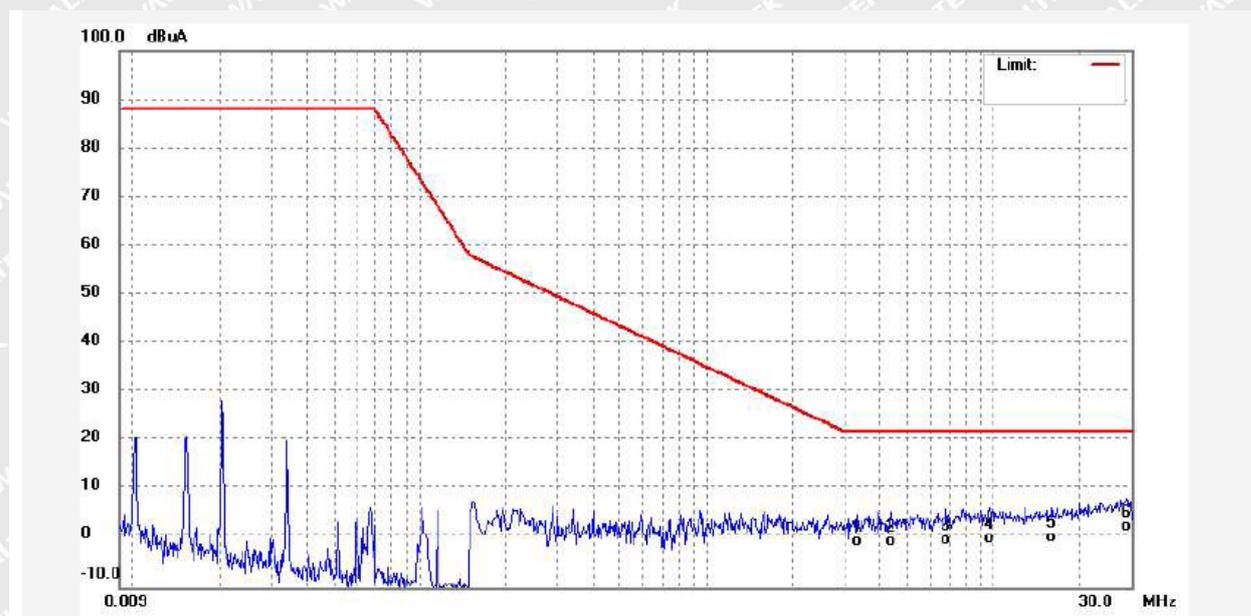
Loop X



No.	Freq. (MHz)	Reading (dBuA)	Factor (dB)	Result (dBuA)	Limit dBuA	Margin (dB)	Detector	Remark
1	3.4421	-34.46	33.63	-0.83	22.00	-22.83	QP	
2	4.8061	-34.77	33.65	-1.12	22.00	-23.12	QP	
3	8.0901	-33.71	33.71	0.00	22.00	-22.00	QP	
4	12.1421	-34.47	33.90	-0.57	22.00	-22.57	QP	
5	19.7941	-34.38	34.04	-0.34	22.00	-22.34	QP	
6	29.8741	-33.48	33.61	0.13	22.00	-21.87	QP	



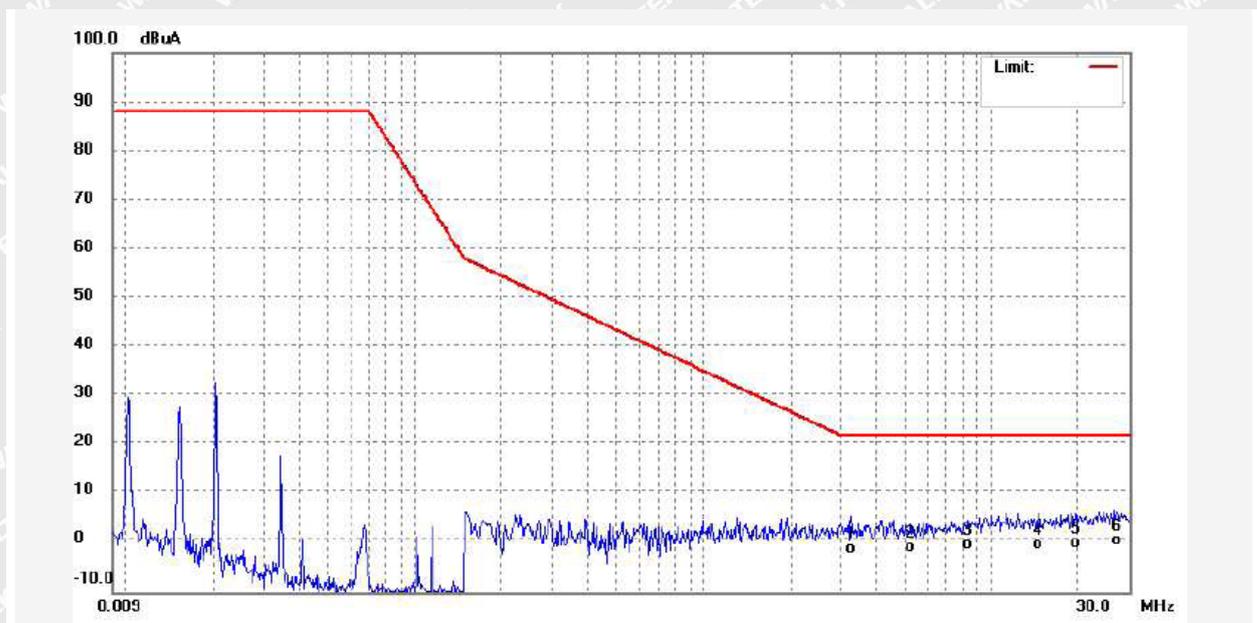
Loop Y



No.	Freq. (MHz)	Reading (dBuA)	Factor (dB)	Result (dBuA)	Limit dBuA	Margin (dB)	Detector	Remark
1	3.3541	-34.06	33.62	-0.44	22.00	-22.44	QP	
2	4.3861	-34.01	33.62	-0.39	22.00	-22.39	QP	
3	6.8381	-34.06	33.74	-0.32	22.00	-22.32	QP	
4	9.5621	-33.70	33.82	0.12	22.00	-21.88	QP	
5	15.8661	-33.62	33.97	0.35	22.00	-21.65	QP	
6	28.9741	-31.03	33.64	2.61	22.00	-19.39	QP	



Loop Z



No.	Freq. (MHz)	Reading (dBuA)	Factor (dB)	Result (dBuA)	Limit dBuA	Margin (dB)	Detector	Remark
1	3.2541	-34.59	33.63	-0.96	22.00	-22.96	QP	
2	5.2581	-34.54	33.69	-0.85	22.00	-22.85	QP	
3	8.2701	-33.83	33.64	-0.19	22.00	-22.19	QP	
4	14.5421	-34.45	34.13	-0.32	22.00	-22.32	QP	
5	19.6221	-34.41	34.42	0.01	22.00	-21.99	QP	
6	27.0501	-33.88	34.41	0.53	22.00	-21.47	QP	



6.3 Radiated Disturbance, 30 MHz to 1 GHz

Test Requirement.....	: EN IEC 55015
Test Method.....	: CISPR 16-2-3
Test Result.....	: Pass
Frequency Range.....	: 30 MHz to 1 GHz
Class/Severity	: Table 10 of EN IEC 55015

6.3.1 E.U.T. Operation

Operating Environment:

Temperature..... : 22.4 °C

Humidity..... : 50%RH

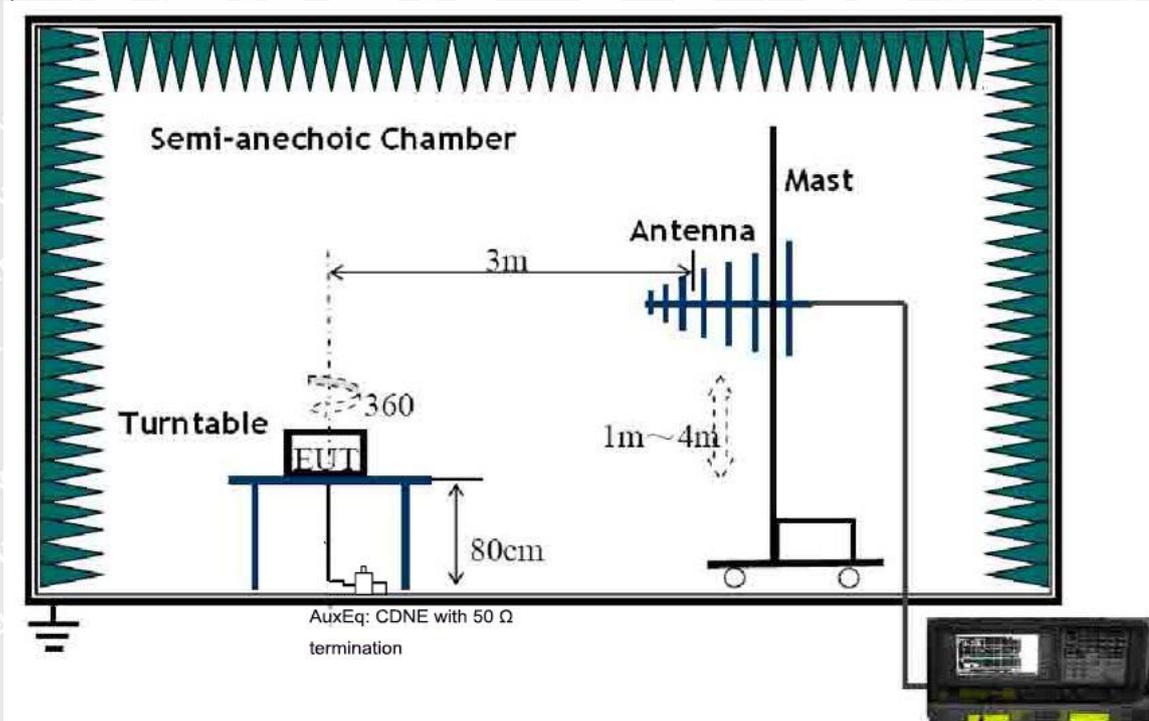
EUT Operation:

Input Voltage..... : 230 Vac, 50 Hz

Operating Mode..... : Max time + Max lux + Max sens mode

6.3.2 Block Diagram of Setup

The Radiated Disturbance tests were performed in the 3 m Semi-Anechoic Chamber test site, using the setup accordance with the CISPR 16-2-3.



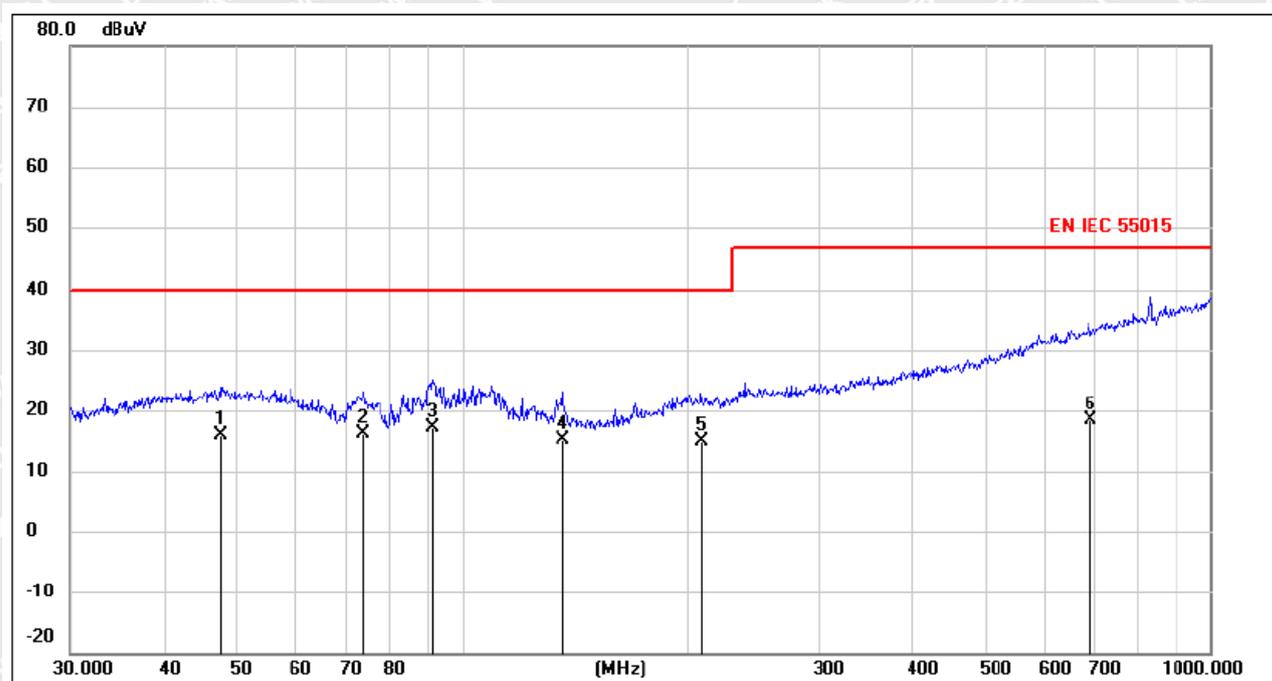
6.3.3 Measurement Data

The maximised peak emissions from the EUT was scanned and measured for Horizontal & Vertical polarisation. Quasi-peak measurements were performed if peak emissions were within 6 dB of the limit line. According to the data in section 6.3.4, the EUT complied with the EN IEC 55015 standards.



6.3.4 Radiated Disturbance Test Data, 30 MHz to 1 GHz

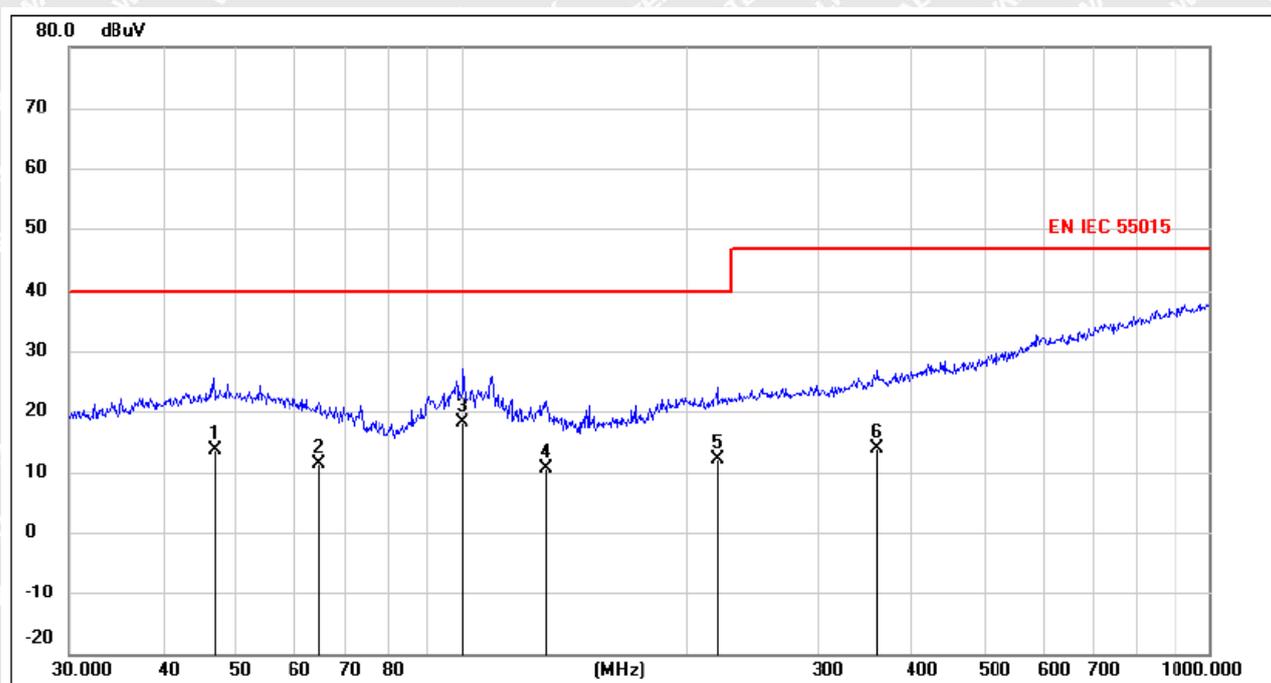
Vertical



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
1	47.6586	1.67	14.28	15.95	40.00	-24.05	QP
2	73.8756	7.42	8.72	16.14	40.00	-23.86	QP
3	91.4949	6.05	11.10	17.15	40.00	-22.85	QP
4	136.4598	6.03	8.98	15.01	40.00	-24.99	QP
5	208.5803	2.58	12.26	14.84	40.00	-25.16	QP
6	689.5644	-4.20	22.52	18.32	47.00	-28.68	QP



Horizontal



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
1	46.8303	-0.62	14.24	13.62	40.00	-26.38	QP
2	64.6594	-0.42	11.71	11.29	40.00	-28.71	QP
3	100.5806	5.42	12.76	18.18	40.00	-21.82	QP
4	129.9225	1.23	9.32	10.55	40.00	-29.45	QP
5	219.8448	-0.10	12.22	12.12	40.00	-27.88	QP
6	360.4476	-1.71	15.65	13.94	47.00	-33.06	QP



6.4 Harmonic Current Emissions

Test Requirement..... : EN IEC 61000-3-2

Test Method..... : EN IEC 61000-3-2

Test Result..... : Pass

Class/Severity : Class C

6.4.1 E.U.T. Operation

Operating Environment:

Temperature : 22.1 °C

Humidity..... : 51.3%RH

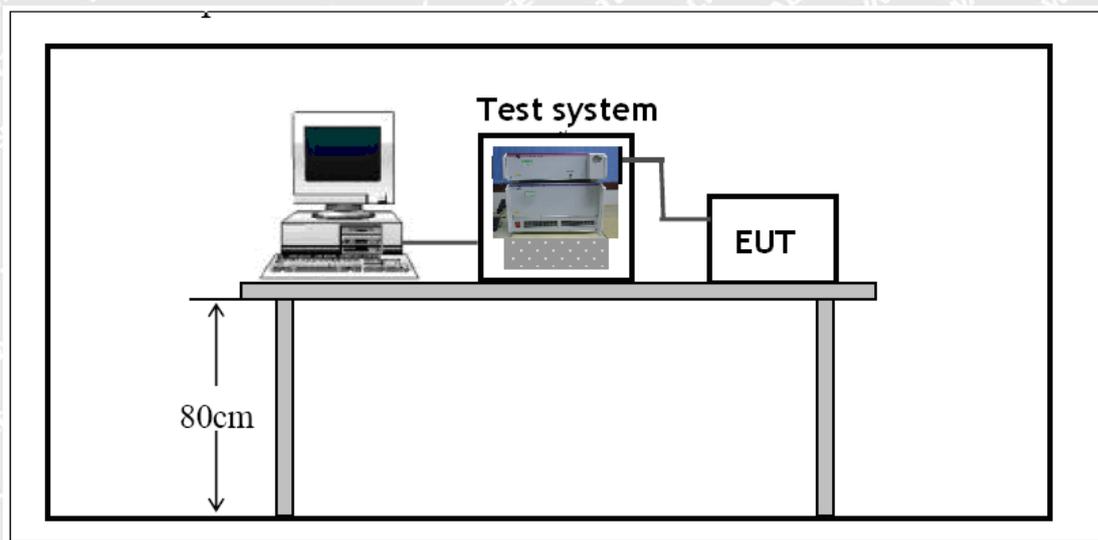
EUT Operation:

Input Voltage : 230 Vac, 50 Hz

Operating Mode..... : Max time + Max lux + Max sens mode

6.4.2 Block Diagram of Setup

The Harmonic Current Emissions test was performed in accordance with the EN IEC 61000-3-2.



**6.4.3 Harmonic Current Emissions Test Data**

Final Test Result	Pass	Tobs	Quasi-Stationary
Voltage	229.88 V	THC	0.0230 A
Current	5.2870 A	POHC/Limit	0.0040 A / 0.5015 A *3
Power	1215.35 W	Nominal	230 V / 50 Hz
Power Factor	1.0000	Fundamental Current	5.2870 A
Apparent Power	1215.4 VA	Measuring Period	150 s
THD (max)	0.54 %	Margin	100 %

Order	Limit1(A rms)	Limit2(A rms)	Ave(A rms)	Max(A rms)	Judge
1	----	----	5.2697	5.2870	N/A
2	0.1057	0.1586	0.0011	0.0110	N/A
3	1.4274	2.1412	0.0011	0.0120	N/A
4	----	----	0.0001	0.0070	N/A
5	0.5287	0.7931	0.0030	0.0080	N/A
6	----	----	0.0000	0.0050	N/A
7	0.3701	0.5551	0.0012	0.0050	N/A
8	----	----	0.0010	0.0040	N/A
9	0.2644	0.3965	0.0010	0.0040	N/A
10	----	----	0.0000	0.0030	N/A
11	0.1586	0.2379	0.0000	0.0030	N/A
12	----	----	0.0000	0.0020	N/A
13	0.1586	0.2379	0.0000	0.0020	N/A
14	----	----	0.0000	0.0020	N/A
15	0.1586	0.2379	0.0008	0.0030	N/A
16	----	----	0.0004	0.0020	N/A
17	0.1586	0.2379	0.0010	0.0020	N/A
18	----	----	0.0000	0.0010	N/A
19	0.1586	0.2379	0.0010	0.0020	N/A
20	----	----	0.0000	0.0010	N/A
21	0.2379	0.2379	0.0010	0.0020	N/A
22	----	----	0.0000	0.0010	N/A
23	0.2379	0.2379	0.0010	0.0020	N/A
24	----	----	0.0000	0.0010	N/A
25	0.2379	0.2379	0.0010	0.0020	N/A
26	----	----	0.0000	0.0010	N/A
27	0.2379	0.2379	0.0004	0.0010	N/A
28	----	----	0.0000	0.0010	N/A
29	0.2379	0.2379	0.0000	0.0010	N/A
30	----	----	0.0000	0.0010	N/A
31	0.2379	0.2379	0.0000	0.0010	N/A
32	----	----	0.0000	0.0010	N/A
33	0.2379	0.2379	0.0000	0.0010	N/A
34	----	----	0.0000	0.0010	N/A
35	0.2379	0.2379	0.0000	0.0010	N/A
36	----	----	0.0000	0.0010	N/A
37	0.2379	0.2379	0.0000	0.0010	N/A
38	----	----	0.0000	0.0010	N/A
39	0.2379	0.2379	0.0000	0.0010	N/A
40	----	----	0.0000	0.0010	N/A

N/A : Not Apply



6.5 Voltage Changes, Voltage Fluctuations and Flicker

Test Requirement : EN 61000-3-3

Test Method..... : EN 61000-3-3

Test Result : Pass

6.5.1 E.U.T. Operation

Operating Environment:

Temperature : 22.1°C

Humidity..... : 51.3%RH

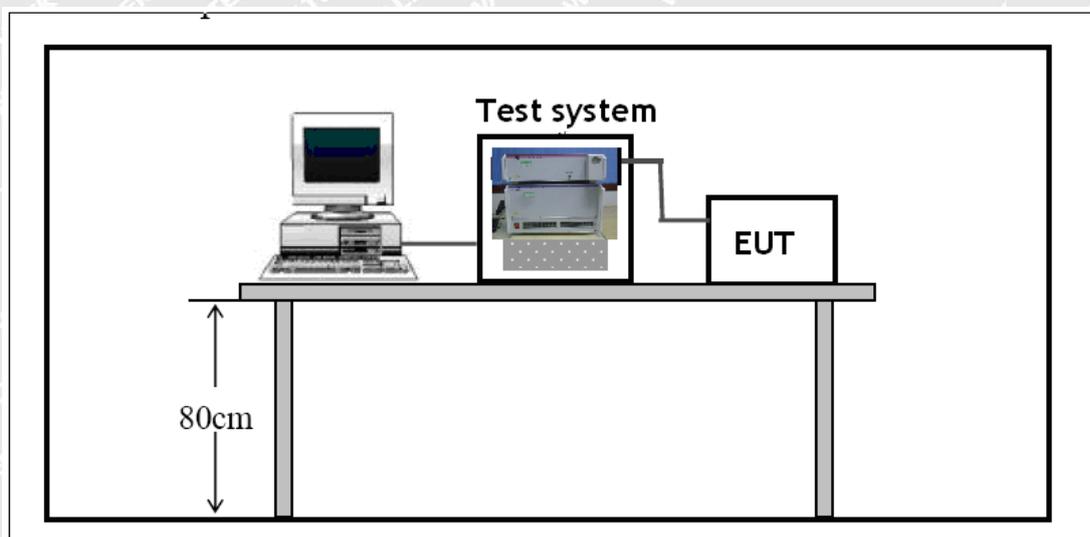
EUT Operation:

Input Voltage : 230 Vac, 50 Hz

Operating Mode..... : Max time + Max lux + Max sens mode

6.5.2 Block Diagram of Setup

The Voltage Changes, Voltage Fluctuations and Flicker test was performed in accordance with the EN 61000-3-3.



6.5.3 Voltage Changes, Voltage Fluctuations and Flicker Test Data

	d_c (%)	d_{max} (%)	$d(t)$	P_{st}	P_{it}
Limits	3.3	4	3.3% / 500 ms	N/A	N/A
Result	0.000	0.039	0	N/A	N/A



7 Immunity Test Results

7.1 Performance Criteria

Performance criterion A: During the test, no change of the luminous intensity shall be observed and the regulating control, if any, shall operate during the test as intended.

Performance criterion B: During the test, the luminous intensity may change to any value. After the test, the luminous intensity shall be restored to its initial value within 1 min (30 min for high pressure gas discharge lamps). Regulating controls need not function during the test, but after the test, the mode of the control shall be the same as before the test provided that during the test no mode changing commands were given.

Performance criterion C: During and after the test, any change of the luminous intensity is allowed and the lamp(s) may be extinguished. After the test, within 30 min, all functions shall return to normal, if necessary by temporary interruption of the mains supply and/or operating the regulating control.

7.2 Electrostatic Discharge (ESD)

Test Requirement.....	:	EN IEC 61547
Test Method.....	:	IEC 61000-4-2
Test Result.....	:	Pass
Discharge Impedance.....	:	330 Ω / 150 pF
Discharge Voltage.....	:	Air Discharge: ± 2 kV, ± 4 kV, ± 8 kV Contact Discharge: ± 4 kV HCP & VCP: ± 4 kV
Polarity.....	:	Positive & Negative
Number of Discharge.....	:	Minimum 10 times at each test point
Discharge Mode.....	:	Single Discharge
Discharge Period.....	:	1 second minimum

7.2.1 E.U.T. Operation

Operating Environment:

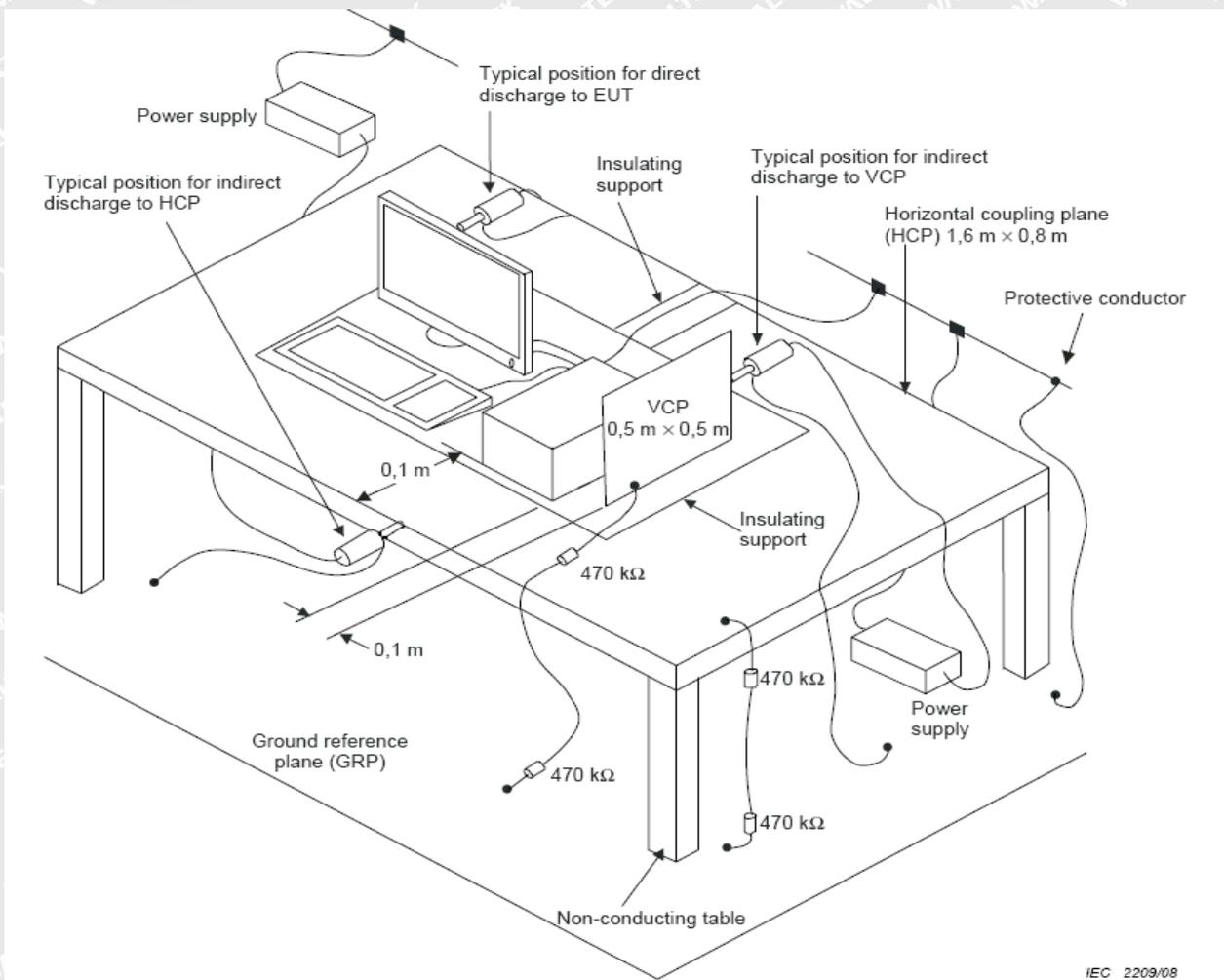
Temperature.....	:	19.9 °C
Humidity.....	:	50.1%RH
Barometric Pressure.....	:	103.4 kPa

EUT Operation:

Input Voltage.....	:	230 Vac, 50 Hz
Operating Mode.....	:	Max time + Max lux + Max sens mode During handling mode

7.2.2 Block Diagram of Setup

The ESD test was performed in accordance with the IEC 61000-4-2.



IEC 2209/08

7.2.3 Direct Discharge Test Results

Observations:

Test points:

1. All Exposed Surface & Seams;
2. All metallic part

Direct Discharge			Test Results		
Applied Voltage (kV)	Performance Criterion	Test Point	Contact Discharge	Air Discharge	Actual performance
± 2, ± 4, ± 8	B	1	N/A	Pass	A*
± 4	B	2	Pass	N/A	A*

Remark:

- * During the test no deviation was detected to the selected operation mode(s).



7.2.4 Indirect Discharge Test Results

Observations:

Test points: 1. All sides.

Indirect Discharge			Test Results		
Applied Voltage (kV)	Performance Criterion	Test Point	Horizontal Coupling	Vertical Coupling	Actual performance
± 4	B	1	Pass	Pass	A*

Remark:

* During the test no deviation was detected to the selected operation mode(s).

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7.3 Radio-frequency Electromagnetic Fields, 80 MHz to 1 GHz

Test Requirement	:	EN IEC 61547
Test Method	:	IEC 61000-4-3
Test Result	:	Pass
Frequency Range	:	80 MHz to 1 GHz
Test level	:	3 V/m
Modulation	:	80%, 1 kHz Amplitude Modulation.
Face of EUT	:	Front, Back, Left, Right
Antenna polarisation	:	Horizontal & Vertical

7.3.1E.U.T. Operation

Operating Environment:

Temperature	:	22.4 °C
Humidity	:	50%RH

EUT Operation:

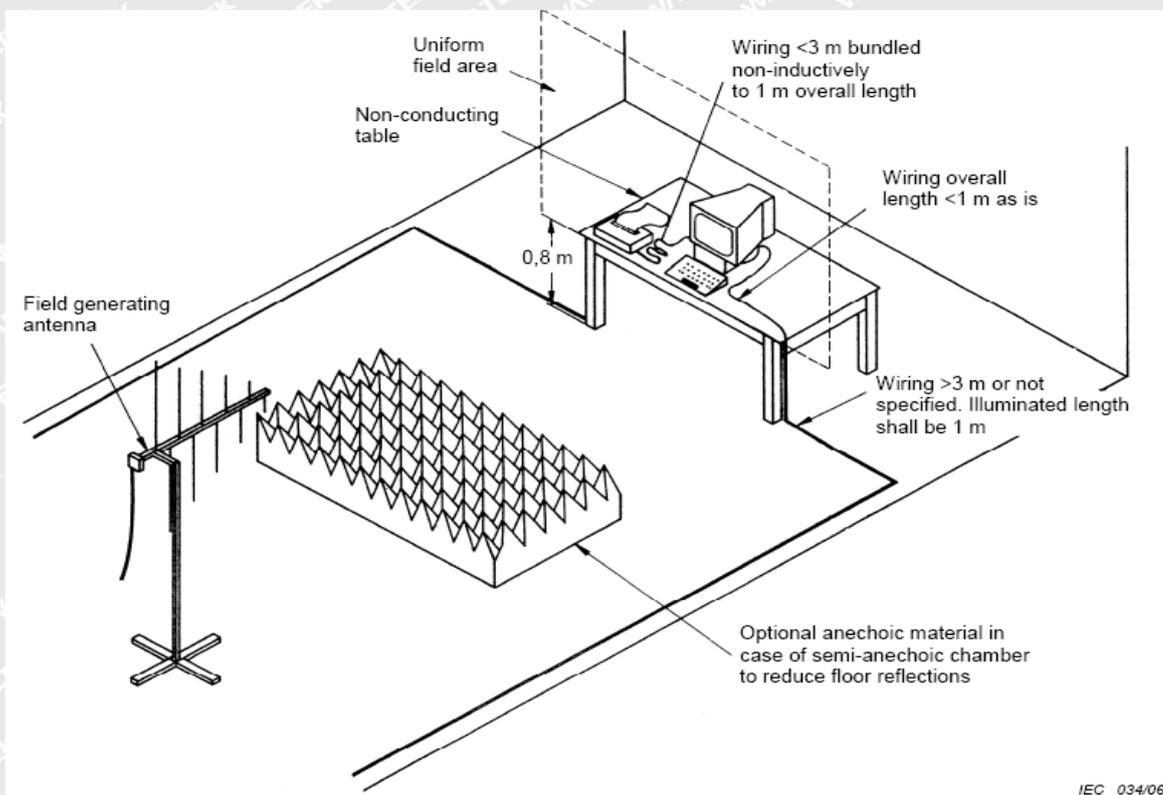
Input Voltage	:	230 Vac, 50 Hz
Operating Mode	:	Min time + Min lux + Max sens mode

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7.3.2 Block Diagram of Setup

The Radio-frequency Electromagnetic Fields Immunity test was performed in accordance with the IEC 61000-4-3.



IEC 034/06

7.3.3 Test Results

Frequency	Face of EUT	Antenna polarisation	Test Level	Step Size	Dwell Time	Performance Criterion	Result	Actual performance
80 to 1000 MHz	Front, Back, Left, Right	Horizontal	3 V/m	1%	3 s	A	Pass	A*
80 to 1000 MHz	Front, Back, Left, Right	Vertical	3 V/m	1%	3 s	A	Pass	A*

Remark:

* During the test no deviation was detected to the selected operation mode(s).



7.4 Fast Transients (EFT)

Test Requirement	:	EN IEC 61547
Test Method	:	IEC 61000-4-4
Test Result	:	Pass
Test Level	:	1.0 kV on AC Mains
Polarity	:	Positive & Negative
Repetition Frequency	:	5 kHz
Burst Duration	:	300 ms
Test Duration	:	2 minutes per level & polarity

7.4.1E.U.T. Operation

Operating Environment:

Temperature	:	19.9 °C
Humidity	:	50.1%RH

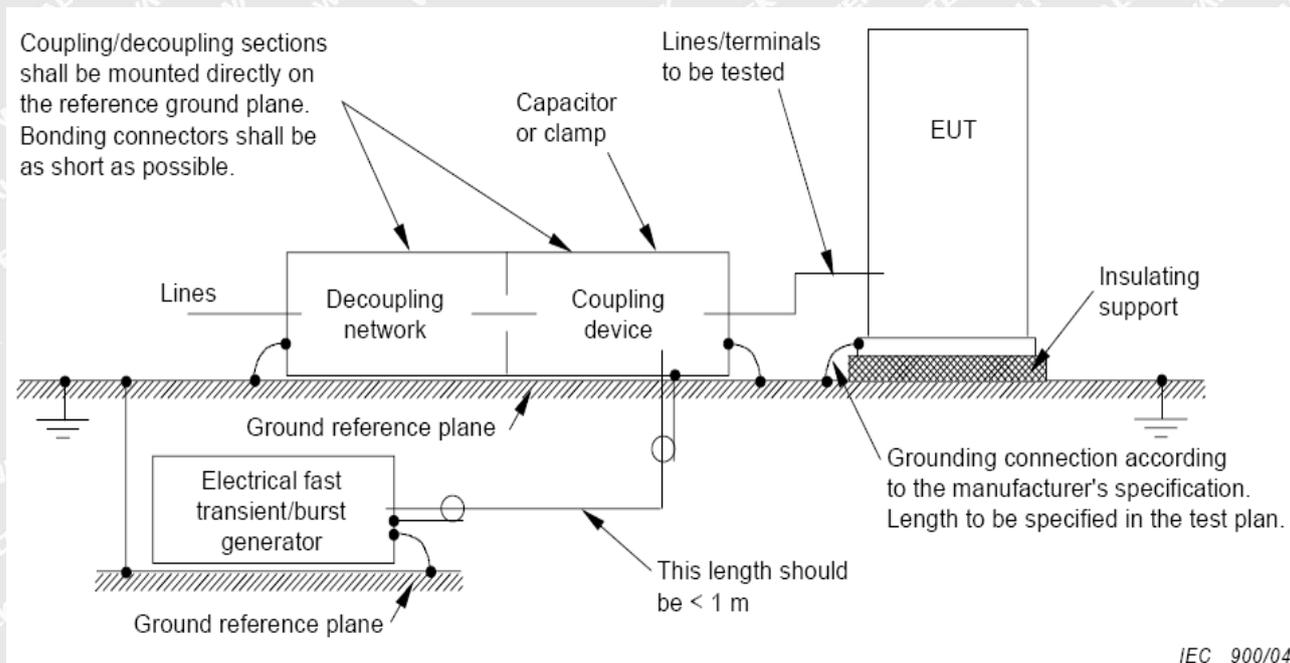
EUT Operation:

Input Voltage	:	230 Vac, 50 Hz
Operating Mode	:	Max time + Max lux + Max sens mode

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7.4.2 Block Diagram of Setup

The Fast Transients Immunity test was performed in accordance with the IEC 61000-4-4.



7.4.3 Test Results

Test Port	Test Level(kV)	Performance Criterion	Result	Actual performance
Line-Neutral	± 1.0	B	Pass	A*

Remark:

* During the test no deviation was detected to the selected operation mode(s).



7.5 Surges

Test Requirement..... : EN IEC 61547
Test Method..... : IEC 61000-4-5
Test Result..... : Pass
Test level..... : Table 10 of EN IEC 61547
Interval..... : 60 s between each surge
No. of surges..... : 5 positive at 90°, 5 negative at 270°.

7.5.1 E.U.T. Operation

Operating Environment:

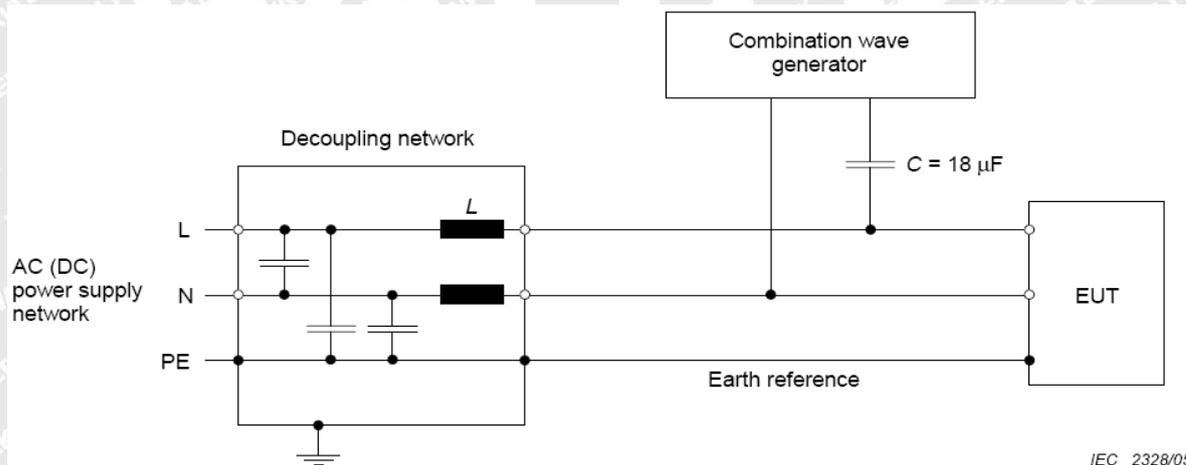
Temperature..... : 23.1 °C
Humidity..... : 51.5%RH

EUT Operation:

Input Voltage..... : 230 Vac, 50 Hz
Operating Mode..... : Max time + Max lux + Max sens mode

7.5.2 Block Diagram of Setup

The Surges Immunity test was performed in accordance with the IEC 61000-4-5.



IEC 2328/05

7.5.3 Test Results

Test Port	Applied Voltage (kV)	Performance criterion	Result	Actual performance
Between Live to Neutral	± 0.5 / 1	C	Pass	B*
Between Live to Earth	± 0.5 / 1 / 2	C	N/A	N/A
Between Neutral to Earth	± 0.5 / 1 / 2	C	N/A	N/A

Remark:

* During the test, the EUT flickered. After the test, the EUT automatically returned to its original working state within 1 min.



7.6 Injected Currents Immunity, 0.15 MHz to 80 MHz

- Test Requirement**..... : EN IEC 61547
- Test Method**..... : IEC 61000-4-6
- Test Result**..... : Pass
- Frequency Range**..... : 0.15 MHz to 80 MHz
- Test level**..... : 3 Vr.m.s. (unmodulated emf into 150 Ω)
- Modulation**..... : 80%, 1 kHz Amplitude Modulation.

7.6.1 E.U.T. Operation

Operating Environment:

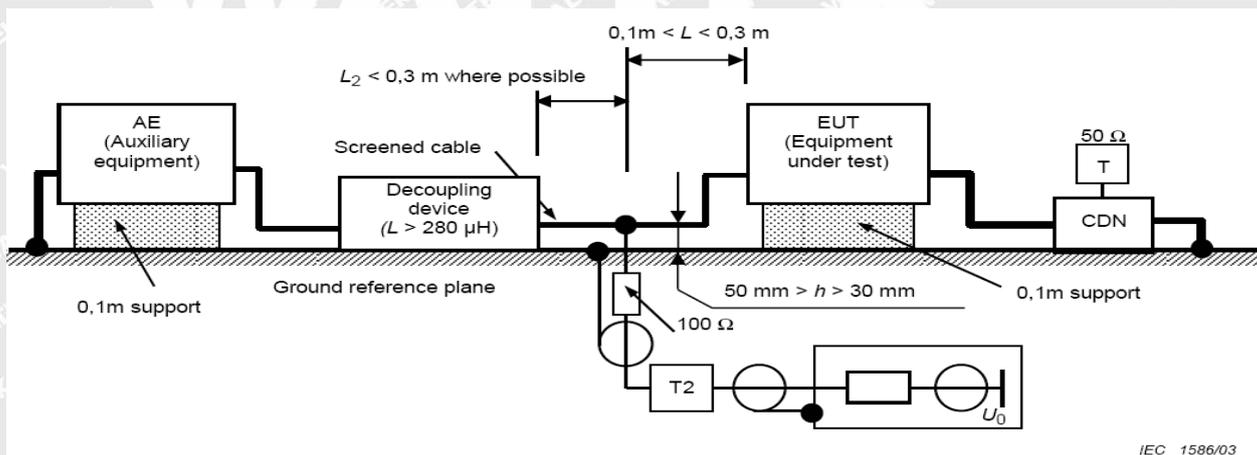
- Temperature**..... : 21.9 °C
- Humidity**..... : 52.3%RH

EUT Operation:

- Input Voltage**..... : 230 Vac, 50 Hz
- Operating Mode**..... : Min time + Min lux + Max sens mode

7.6.2 Block Diagram of Setup

The Injected Currents Immunity test was performed in accordance with the IEC 61000-4-6.



7.6.3 Test Results

Frequency	Line	Test Level	Modulation	Step Size	Dwell Time	Performance Criterion	Result	Actual performance
0.15 MHz to 80 MHz	2 Wire AC Supply Cables	3 Vr.m.s.	80%, 1 kHz Amp. Mod.	1%	3 s	A	Pass	A*

Remark:

* During the test no deviation was detected to the selected operation mode(s).



7.7 Voltage Dips and Short Interruptions

Test Requirement.....	: EN IEC 61547
Test Method.....	: IEC 61000-4-11
Test Result.....	: Pass
Test Level (Voltage reduction)	: 0% & 70% of U_T (Supply Voltage)
No. of Dips / Interruptions.....	: 1 per Level at 20 ms intervals

7.7.1 E.U.T. Operation

Operating Environment:

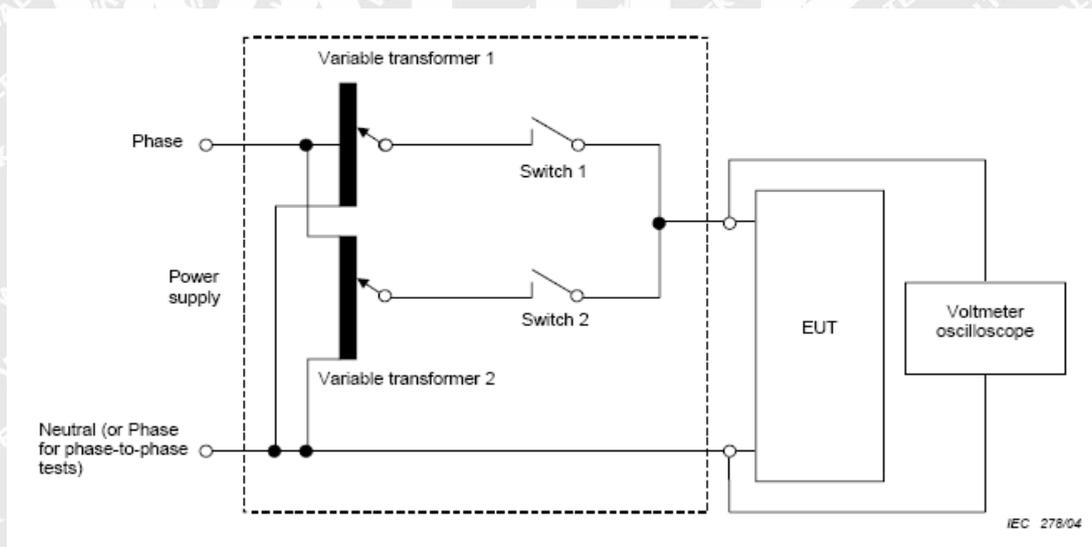
Temperature.....	: 19.9 °C
Humidity.....	: 50.1%RH

EUT Operation:

Input Voltage.....	: 230 Vac, 50 Hz
Operating Mode.....	: Max time + Max lux + Max sens mode

7.7.2 Block Diagram of Setup

The Voltage Dips and Short Interruptions Immunity test was performed in accordance with the IEC 61000-4-11.



7.7.3 Test Results

Test Level in % U_T	Phase	Performance criterion	Duration	Result	Actual performance
0	0° & 180°	B	0.5	Pass	A*
70	0° & 180°	B	10	Pass	A*

Remark:

- * During the test no deviation was detected to the selected operation mode(s).



8 Photographs – Test Setup

8.1 Photograph – Electric Power Supply Interface Disturbance Voltage Test Setup



8.2 Photograph – Radiated Disturbance Test Setup, 9 kHz to 30 MHz





8.3 Photograph – Radiated Disturbance Test Setup, 30 MHz to 1 GHz

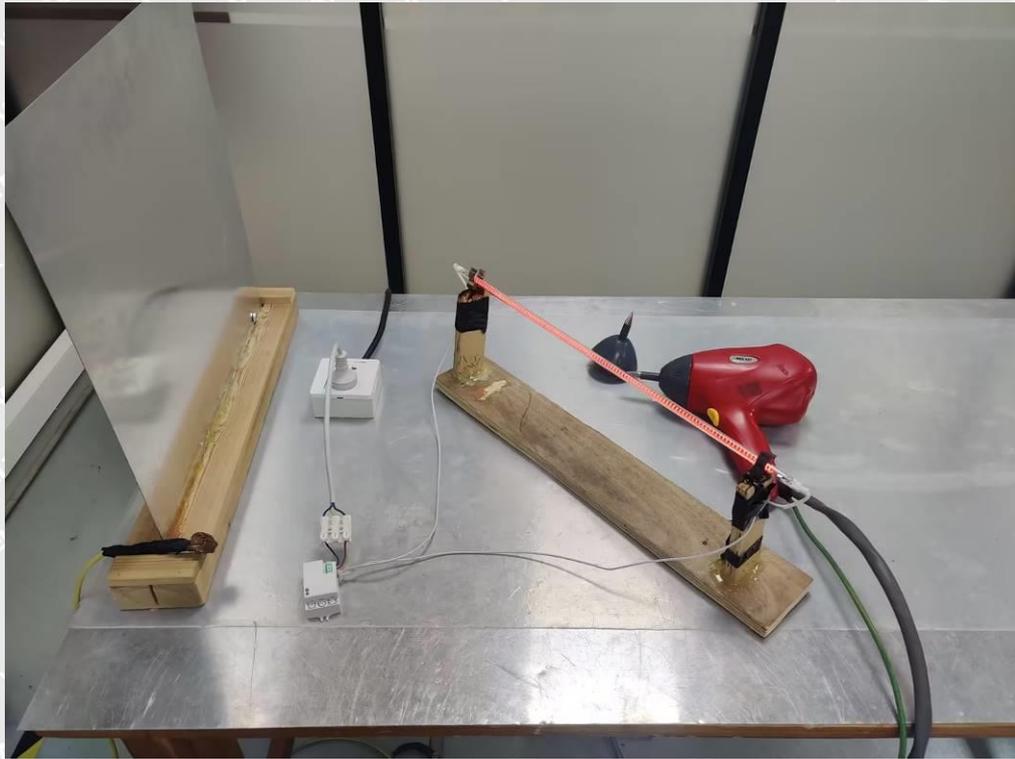


8.4 Photograph – Harmonic Current and Voltage Changes, Voltage Fluctuation and Flicker Test Setup





8.5 Photograph – ESD Immunity Test Setup

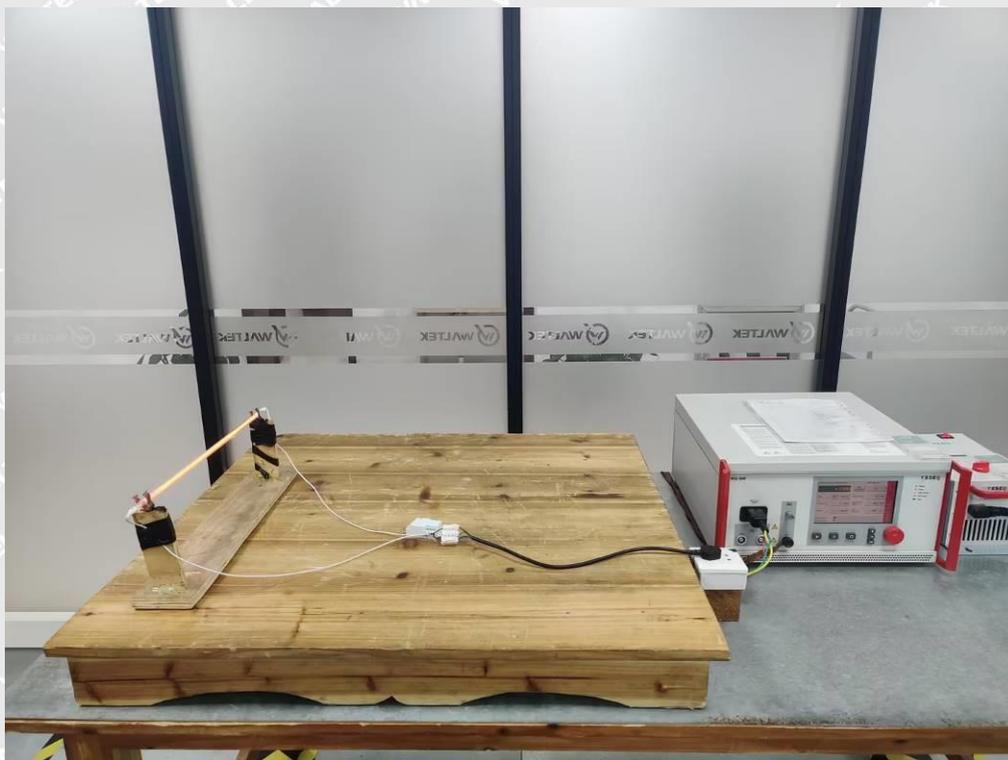


8.6 Photograph – Radio-frequency Electromagnetic Fields Immunity Test Setup





8.7 Photograph – EFT & Voltage Dips and Short Interruptions Immunity Test Setup

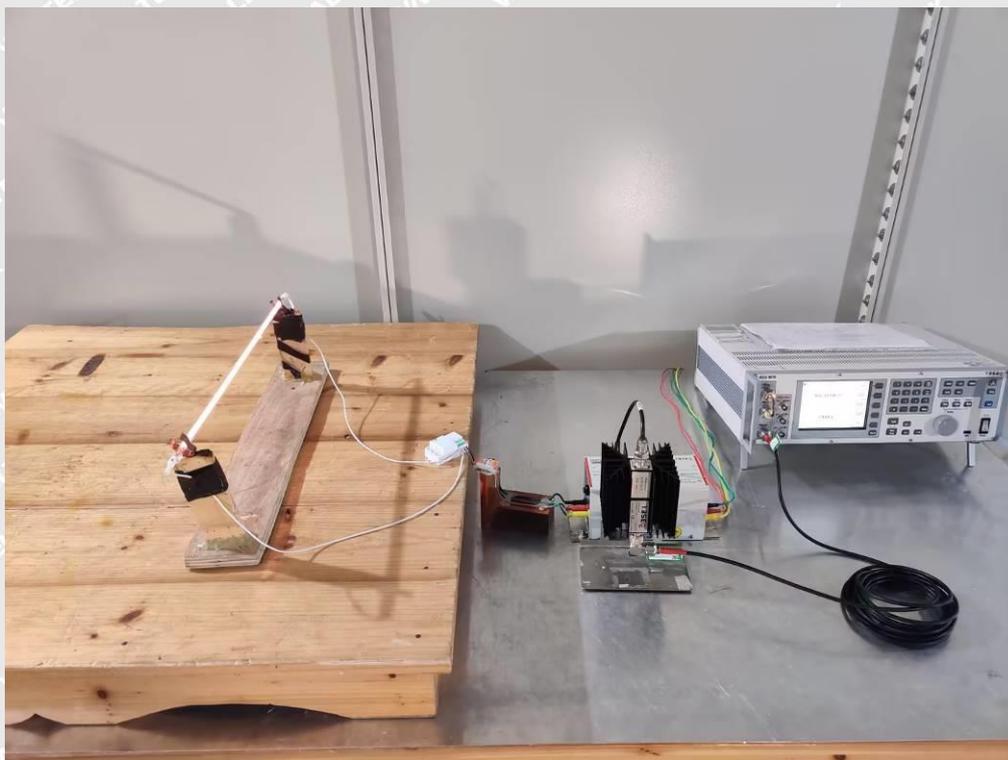


8.8 Photograph – Surges Immunity Test Setup





8.9 Photograph – Injected Currents Immunity Test Setup

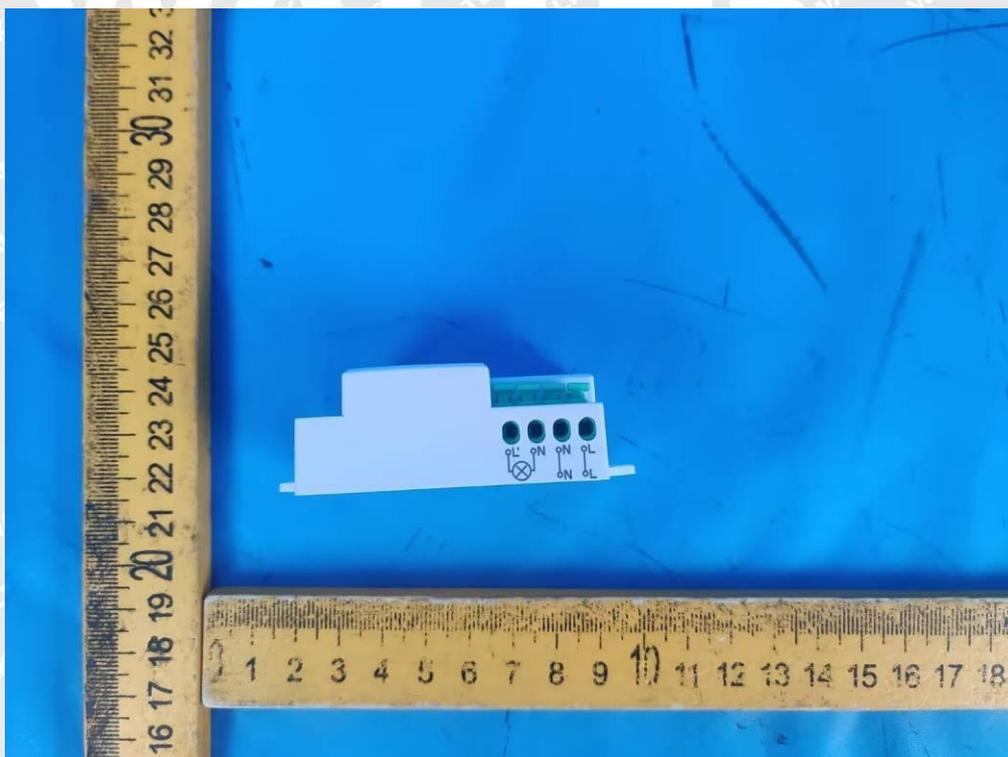
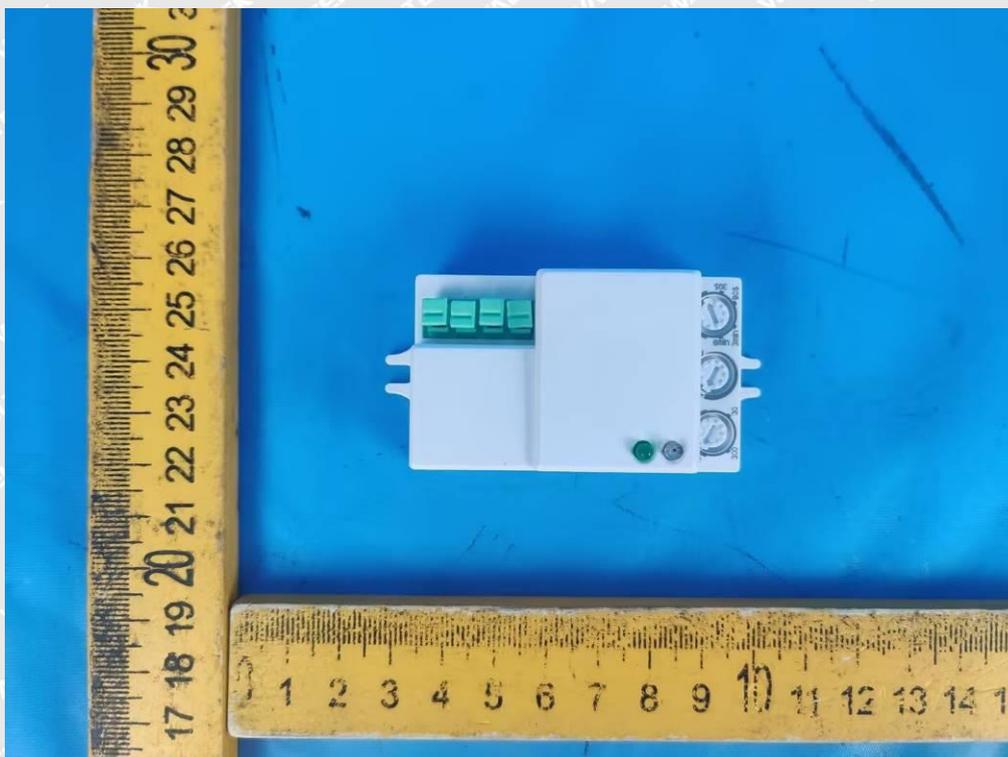


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9 Photographs – Constructional Details

9.1 Photo – Appearance View



=====End of Report=====